Preferred Devices

5.6 Volt through 33 Volt SOT-23 Dual Monolithic Common Anode Zeners

Transient Voltage Suppressors for ESD Protection

These dual monolithic silicon zener diodes are designed for applications requiring transient overvoltage protection capability. They are intended for use in voltage and ESD sensitive equipment such as computers, printers, business machines, communication systems, medical equipment and other applications. Their dual junction common anode design protects two separate lines using only one package. These devices are ideal for situations where board space is at a premium.

Specification Features:

- SOT–23 Package Allows Either Two Separate Unidirectional Configurations or a Single Bidirectional Configuration
- Peak Power 24 or 40 Watts @ 1.0 ms (Unidirectional), per Figure 5. Waveform
- Maximum Clamping Voltage @ Peak Pulse Current
- Low Leakage < 5.0 μA
- ESD Rating of Class N (exceeding 16 kV) per the Human Body Model

Mechanical Characteristics:

CASE: Void-free, transfer-molded, thermosetting plastic case **FINISH:** Corrosion resistant finish, easily solderable Package designed for optimal automated board assembly Small package size for high density applications Available in 8 mm Tape and Reel

Use the Device Number to order the 7 inch/3,000 unit reel. Replace the "T1" with "T3" in the Device Number to order the 13 inch/10,000 unit reel.

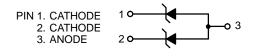
DEVICE MARKING INFORMATION

Device	Device Marking
MMBZ5V6ALT1	5A6
MMBZ5V6ALT3	5A6
MMBZ6V2ALT1	6A2
MMBZ6V2ALT3	6A2
MMBZ6V8ALT1	6A8
MMBZ6V8ALT3	6A8
MMBZ15VALT1	15A
MMBZ15VALT3	15A
MMBZ20VALT1	20A
MMBZ20VALT3	20A
MMBZ33VALT1	33A
MMBZ33VALT3	33A

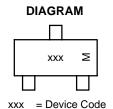


http://onsemi.com

SOT-23 COMMON ANODE DUAL ZENER OVERVOLTAGE TRANSIENT SUPPRESSORS 24 & 40 WATTS PEAK POWER







= Date Code

MARKING

ORDERING INFORMATION

Device	Package	Shipping			
MMBZ5V6ALT1	SOT-23	3000/Tape & Reel			
MMBZ5V6ALT3	SOT-23	10,000/Tape & Reel			
MMBZ6V2ALT1	SOT-23	3000/Tape & Reel			
MMBZ6V2ALT3	SOT-23	10,000/Tape & Reel			
MMBZ6V8ALT1	SOT-23	3000/Tape & Reel			
MMBZ6V8ALT3	SOT-23	10,000/Tape & Reel			
MMBZ15VALT1	SOT-23	3000/Tape & Reel			
MMBZ15VALT3	SOT-23	10,000/Tape & Reel			
MMBZ20VALT1	SOT-23	3000/Tape & Reel			
MMBZ20VALT3	SOT-23	10,000/Tape & Reel			
MMBZ33VALT1	SOT-23	3000/Tape & Reel			
MMBZ33VALT3	SOT-23	10,000/Tape & Reel			

Preferred devices are recommended choices for future use and best overall value

THERMAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Value	Unit
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	P _{pk}	24 40	Watts
Total Power Dissipation on FR–5 Board (Note 2.) @ T _A = 25°C Derate above 25°C	P _D	225 1.8	mW mW/°C
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	556	°C/W
Total Power Dissipation on Alumina Substrate (Note 3.) @ T _A = 25°C Derate above 25°C	P _D	300 2.4	mW mW/°C
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	417	°C/W
Junction and Storage Temperature Range	T _J T _{stg}	- 55 to +150	°C
Lead Solder Temperature – Maximum (10 Second Duration)	TL	260	°C

Other voltages may be available upon request

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

UNIDIRECTIONAL (Circuit tied to Pins 1 and 3 or Pins 2 and 3)

 $(V_F = 0.9 \text{ V Max } @ I_F = 10 \text{ mA})$

24 WATTS

	Br	eakdov	Rev Lea		Rev	Max Reverse Leakage Max Zener Current Impedance (Note 6.)				Max Reverse Surge Current	Max Reverse Voltage @ IRSM (Note 5.)	Max Temp Coeffi- cient	tar @ 0 Bi	aci- ice Volt as, IHz F)
	V _{BR}	(Note 4	.) (V)	@ h	@ I _T I _R @ V _R		Z _{ZT} @ I _{ZT}	Z _{ZK} (@ Hzv	I _{RSM} (Note 5.)	(Clamping Voltage)	of V _{BR}		
Device	Min	Nom	Max	(mA)	(μ A)		(Ω) (mA)	(Ω)	(mA)	(A)	V _{RSM} (V)	(mV/°C)	Min	Max
MMBZ5V6ALT1	5.32	5.6*	5.88	20	5.0	3.0	11	1600	0.25	3.0	8.0	1.26	_	_
MMBZ6V2ALT1	5.89	6.2*	6.51	1.0	0.5	3.0	_	_	_	2.76	8.7	2.80	_	_

 $(V_F = 1.1 \text{ V Max } @ I_F = 200 \text{ mA})$

MMBZ6V8ALT1	6.46	6.8	7.14	1.0	0.5	4.5	_	_	_	2.5	9.6	3.40	150	300
														1

 $(V_F = 1.1 \text{ V Max } @ I_F = 200 \text{ mA})$

40 WATTS

	В	Breakdov	vn Voltag	е	Reverse Voltage	Max Reverse	Max Reverse	Max Reverse Voltage @ I _{RSM}	Maximum Temperature	
	V _{BR} (Note 4.) (V)			Working Peak V _{RWM}	Leakage Current	Surge Current I _{RSM}	(Note 5.) (Clamping Voltage)	Coefficient of V _{BR}		
Device	Min	Nom	Max	@ দ (mA)	(V)	I _R (nA)	(Note 5.) (A)	V _{RSM} (V)	(mV/°C)	
MMBZ15VALT1	14.25	15*	15.75	1.0	12.0	50	1.9	21	12.30	
MMBZ20VALT1	19.00	20*	21.00	1.0	17.0	50	1.4	28	17.20	
MMBZ33VALT1	31.35	33	34.65	1.0	26.0	50	0.87	46	30.40	

- 1. Non–repetitive current pulse per Figure 5. and derate above $T_A = 25^{\circ}C$ per Figure 6.
- 2. $FR-5 = 1.0 \times 0.75 \times 0.62$ in.
- 3. Alumina = $0.4 \times 0.3 \times 0.024$ in., 99.5% alumina
- 4. V_{BR} measured at pulse test current I_{T} at an ambient temperature of 25°C.
- 5. Surge current waveform per Figure 5. and derate per Figure 6.
- Z_{ZT} and Z_{ZK} are measured by dividing the AC voltage drop across the device by the AC current supplied. The specfied limits are I_{Z(AC)} = 0.1 I_{Z(DC)}, with AC frequency = 1 kHz.

^{*} Devices are currently in production, and are available in stock

TYPICAL CHARACTERISTICS

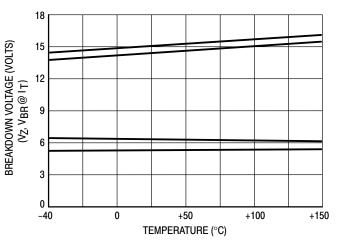


Figure 1. Typical Breakdown Voltage versus Temperature

(Upper curve for each voltage is bidirectional mode, lower curve is unidirectional mode)

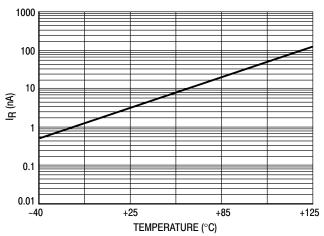


Figure 2. Typical Leakage Current versus Temperature

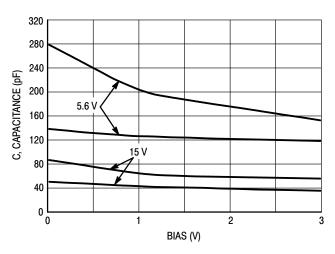


Figure 3. Typical Capacitance versus Bias Voltage (Upper curve for each voltage is unidirectional mode, lower curve is bidirectional mode)

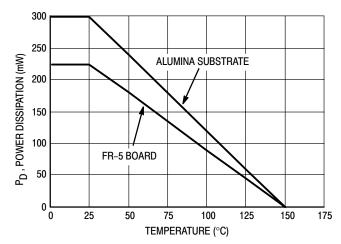


Figure 4. Steady State Power Derating Curve

TYPICAL CHARACTERISTICS

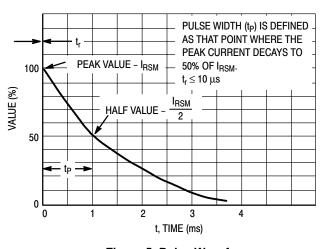


Figure 5. Pulse Waveform

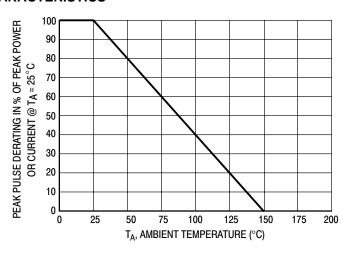


Figure 6. Pulse Derating Curve

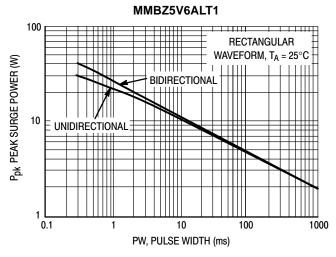


Figure 7. Maximum Non-repetitive Surge Power, Ppk versus PW

Power is defined as $V_{RSM} \ x \ I_Z(pk)$ where V_{RSM} is the clamping voltage at $I_Z(pk).$

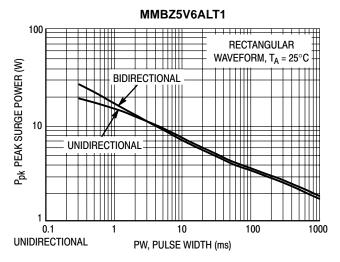


Figure 8. Maximum Non-repetitive Surge Power, Ppk(NOM) versus PW

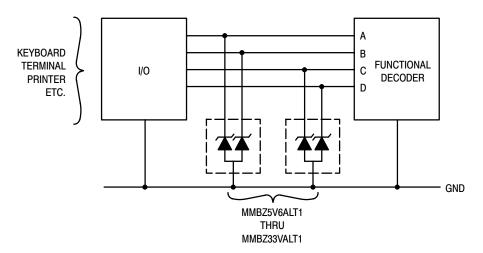
Power is defined as $V_Z(NOM) \times I_Z(pk)$ where $V_Z(NOM)$ is the nominal zener voltage measured at the low test current used for voltage classification.

TYPICAL COMMON ANODE APPLICATIONS

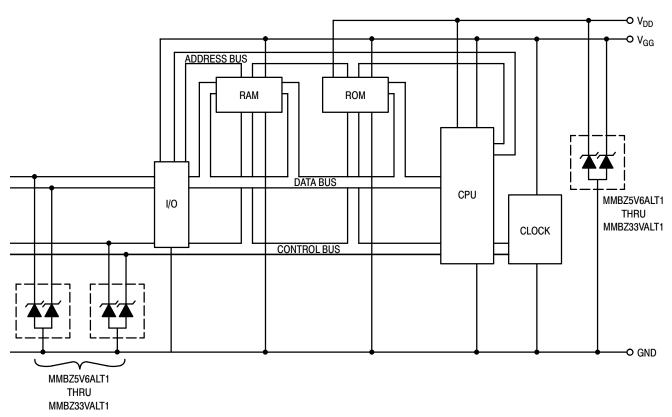
A quad junction common anode design in a SOT-23 package protects four separate lines using only one package. This adds flexibility and creativity to PCB design especially

when board space is at a premium. Two simplified examples of TVS applications are illustrated below.

Computer Interface Protection



Microprocessor Protection

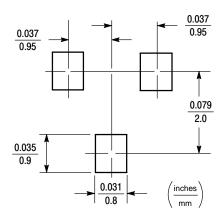


INFORMATION FOR USING THE SOT-23 SURFACE MOUNT PACKAGE

MINIMUM RECOMMENDED FOOTPRINT FOR SURFACE MOUNTED APPLICATIONS

Surface mount board layout is a critical portion of the total design. The footprint for the semiconductor packages must be the correct size to insure proper solder connection

interface between the board and the package. With the correct pad geometry, the packages will self align when subjected to a solder reflow process.



SOT-23

SOT-23 POWER DISSIPATION

The power dissipation of the SOT–23 is a function of the drain pad size. This can vary from the minimum pad size for soldering to a pad size given for maximum power dissipation. Power dissipation for a surface mount device is determined by $T_{J(max)}$, the maximum rated junction temperature of the die, $R_{\theta JA}$, the thermal resistance from the device junction to ambient, and the operating temperature, T_A . Using the values provided on the data sheet for the SOT–23 package, P_D can be calculated as follows:

$$P_{D} = \frac{T_{J(max)} - T_{A}}{R_{\theta JA}}$$

The values for the equation are found in the maximum ratings table on the data sheet. Substituting these values into the equation for an ambient temperature T_A of 25°C, one can calculate the power dissipation of the device which in this case is 225 milliwatts.

$$P_D = \frac{150^{\circ}C - 25^{\circ}C}{556^{\circ}C/W} = 225 \text{ milliwatts}$$

The 556°C/W for the SOT-23 package assumes the use of the recommended footprint on a glass epoxy printed circuit board to achieve a power dissipation of 225 milliwatts. There are other alternatives to achieving higher power dissipation from the SOT-23 package. Another alternative would be to use a ceramic substrate or an aluminum core board such as Thermal Clad $^{\rm TM}$. Using a board material such as Thermal Clad, an aluminum core board, the power dissipation can be doubled using the same footprint.

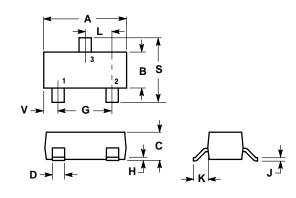
SOLDERING PRECAUTIONS

The melting temperature of solder is higher than the rated temperature of the device. When the entire device is heated to a high temperature, failure to complete soldering within a short time could result in device failure. Therefore, the following items should always be observed in order to minimize the thermal stress to which the devices are subjected.

- Always preheat the device.
- The delta temperature between the preheat and soldering should be 100°C or less.*
- When preheating and soldering, the temperature of the leads and the case must not exceed the maximum temperature ratings as shown on the data sheet. When using infrared heating with the reflow soldering method, the difference shall be a maximum of 10°C.
- The soldering temperature and time shall not exceed 260°C for more than 10 seconds.
- When shifting from preheating to soldering, the maximum temperature gradient shall be 5°C or less.
- After soldering has been completed, the device should be allowed to cool naturally for at least three minutes.
 Gradual cooling should be used as the use of forced cooling will increase the temperature gradient and result in latent failure due to mechanical stress.
- Mechanical stress or shock should not be applied during cooling.
- * Soldering a device without preheating can cause excessive thermal shock and stress which can result in damage to the device.

Transient Voltage Suppressors – Surface Mount

24 & 40 Watts Peak Power



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL MATERIAL.

	INC	HES	MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.1102	0.1197	2.80	3.04
В	0.0472	0.0551	1.20	1.40
С	0.0350	0.0440	0.89	1.11
D	0.0150	0.0200	0.37	0.50
G	0.0701	0.0807	1.78	2.04
Н	0.0005	0.0040	0.013	0.100
J	0.0034	0.0070	0.085	0.177
K	0.0140	0.0285	0.35	0.69
L	0.0350	0.0401	0.89	1.02
S	0.0830	0.1039	2.10	2.64
٧	0.0177	0.0236	0.45	0.60

STYLE 12:

PIN 1. CATHODE 2. CATHODE

3. ANODE

CASE 318-08 LOW PROFILE SOT-23 PLASTIC

(Refer to Section 10 of the TVS/Zener Data Book (DL150/D) for Surface Mount, Thermal Data and Footprint Information.)

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